

Description

The HXY4407S uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features SOP-8

 $V_{DS} = -30V I_{D} = -12A$

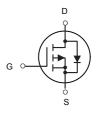
 $R_{DS(ON)}$ < 15m Ω @ V_{GS} =10V

Application

Battery protection

Load switch

Uninterruptible power supply



P-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
HXY4407S	SOP-8	4407 XXXX	3000

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	-30	V
Vgs	Gate-Source Voltage	<u>+</u> 20	V
I _D @T _A =25°C	Drain Current³, V _{GS} @ 10V	-12	А
I _D @T _A =70°C	Drain Current³, V _{GS} @ 10V	-9.1	А
Ірм	Pulsed Drain Current ¹	-40	А
P _D @T _A =25°C	Total Power Dissipation	2.5	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Rthj-a	Maximum Thermal Resistance, Junction- ambient ³	50	°C/W



Electrical Characteristics@T_j=25°C(unless otherwise specified)

Parameter Drain-Source Breakdown Voltage Static Drain-Source On- Resistance ²	Test Conditions V _{GS} =0V, I _D =-250uA	Min. -30	Тур.	Max.	Units
Static Drain-Source On-	•	-30			
			-	-	V
	V _{GS} =-10V, I _D =-10A	-	9.5	15	mΩ
i tosistarioc	V _{GS} =-4.5V, I _D =-6A	-	15	25	mΩ
Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250uA	-1	1	-2.5	V
Forward Transconductance	V _{DS} =-10V, I _D =-10A	-	22	-	S
Drain-Source Leakage Current	V _{DS} =-24V, V _{GS} =0V	-	-	-10	uA
Gate-Source Leakage	V _{GS} = <u>+</u> 20V, V _{DS} =0V	-	-	<u>+</u> 100	nA
Total Gate Charge	I _D =-6A	-	28	45	nC
Gate-Source Charge	V _{DS} =-15V	-	7	-	nC
Gate-Drain ("Miller") Charge	V _{GS} =-4.5V	-	11	-	nC
Turn-on Delay Time	V _{DS} =-15V	-	13	-	ns
Rise Time	I _D =-1A	-	10	-	ns
Turn-off Delay Time		-	80	-	ns
Fall Time	V _{GS} =-10V	-	37	-	ns
Input Capacitance	V _{GS} =0V V _{DS} =-	-	2940	4700	pF
Output Capacitance	15V f=1.0MHz	-	290	-	pF
Reverse Transfer Capacitance		-	210	-	pF
Gate Resistance	f=1.0MHz	-	6.2	12.4	Ω
Forward On Voltage ²	Is=-2.1A, V _{GS} =0V	-	-	-1.2	V
Reverse Recovery Time	I _S =-10A, V _{GS} =0V, dI/dt=100A/μs	-	19	-	ns
Reverse Recovery Charge		-	6	-	nC
	Gate Threshold Voltage Forward Transconductance Drain-Source Leakage Current Gate-Source Leakage Total Gate Charge Gate-Source Charge Gate-Drain ("Miller") Charge Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time Input Capacitance Reverse Transfer Capacitance Gate Resistance Forward On Voltage ² Reverse Recovery Time	V _{GS} =-4.5V, I _D =-6A Gate Threshold Voltage Forward Transconductance V _{DS} =-10V, I _D =-10A Orain-Source Leakage Current Gate-Source Leakage V _{GS} =±20V, V _{DS} =0V Total Gate Charge Gate-Source Charge Gate-Drain ("Miller") Charge Furn-on Delay Time Furn-off Delay Time Fall Time Total Capacitance Output Capacitance Gate Resistance Gate Resistance Forward On Voltage ² Reverse Recovery Time V _{DS} =-10V, V _{DS} =-0V V _{DS} =-24V, V _{DS} =0V V _{DS} =-24V, V _{DS} =0V V _{DS} =-15V I _D =-1A R _G =3.3Ω V _{GS} =-10V V _{GS} =0V V _{DS} =-15V I _D =-1A Reverse Transfer Capacitance Gate Resistance F=1.0MHz Reverse Recovery Time I _S =-10A, V _{GS} =0V, dl/dt=100A/µs	V _{GS} =-4.5V, I _D =-6A - Common V _{DS} =V _{GS} , I _D =-250uA -1 Common V _{DS} =-10V, I _D =-10A -1 Common V _{DS} =-10V, I _D =-10A -1 Common V _{DS} =-24V, V _{GS} =0V -1 Common V _{DS} =-24V, V _{DS} =0V -1 Common V _{DS} =-24V, V _{DS} =0V -1 Common V _{DS} =-24V, V _{DS} =0V -1 Common V _{DS} =-15V -1 Common V _{DS} =-10V -	V _{GS} =-4.5V, I _D =-6A - 15	V _{GS} =-4.5V, I _D =-6A

Notes:

^{1.} Pulse width limited by Max. junction temperature.

^{2.}Pulse test

^{3.}Surface mounted on 1 in 2 copper pad of FR4 board, t \leq 10s; 125 °C/W when mounted on Min. copper pad.



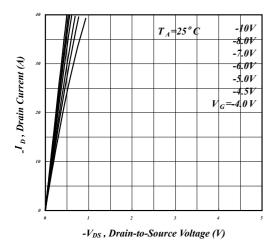


Fig 1. Typical Output Characteristics

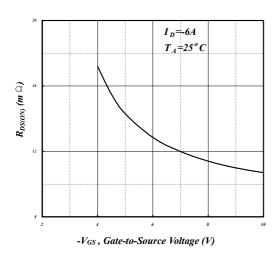
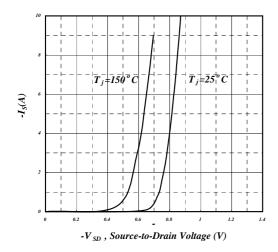


Fig 3. On-Resistance v.s. Gate Voltage



Reverse Diode

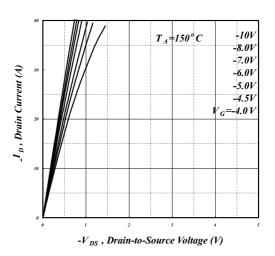


Fig 2 Typical Output Characteristics

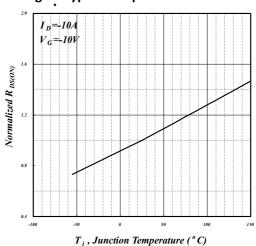


Fig 4. Normalized On-Resistance v.s. Junction Temperature

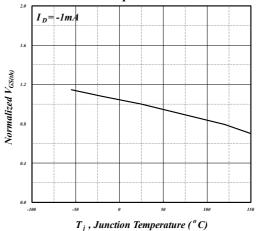


Fig 6. Gate Threshold Voltage v.s. Junction Temperatur



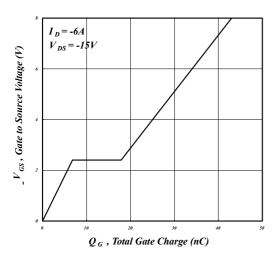


Fig 7. Gate Charge Characteristics

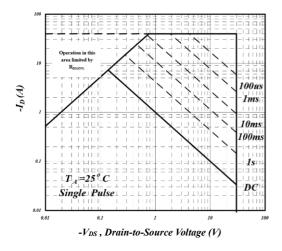


Fig 9. Maximum Safe Operating Area

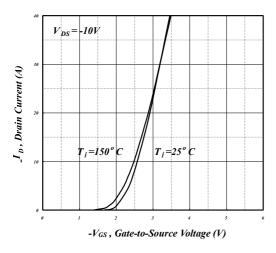


Fig 11. Transfer Characteristics

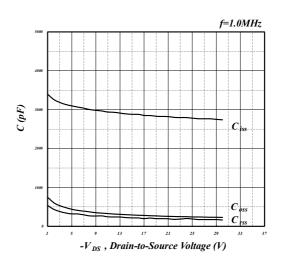


Fig 8. Typical Capacitance Characteristics

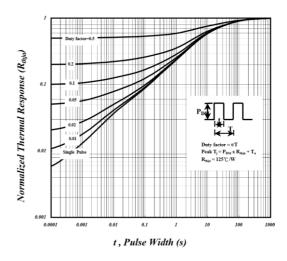


Fig 10. Effective Transient Thermal Impedance

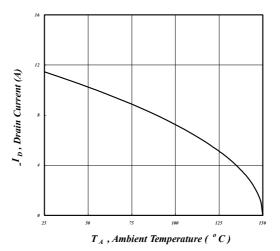
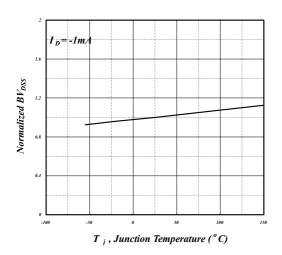


Fig 12. Drain Current v.s. Ambient Temperature





 $\label{eq:posterior} \mbox{Fig 13. Normalized BV}_{DSS} \ \ \mbox{v.s.} \\ \mbox{JunctionTemperature}$

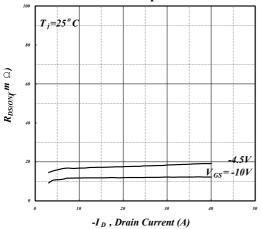


Fig 15. Typ. Drain-Source on State Resistance

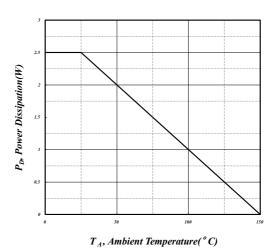
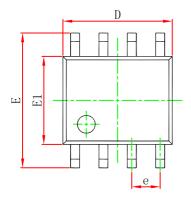
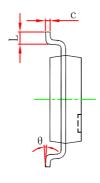


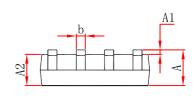
Fig 14. Total Power Dissipation



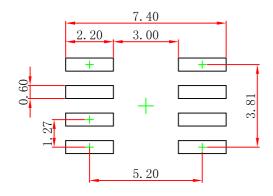
SOP-8 Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches	
Symbol	Min	Max	Min	Max
A	1. 350	1. 750	0.053	0.069
A1	0.100	0. 250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0. 250	0.007	0.010
D	4.800	5.000	0.189	0. 197
e	1.270 (BSC)		0.050 (BSC)	
E	5.800	6. 200	0.228	0. 244
E1	3.800	4.000	0.150	0. 157
L	0.400	1. 270	0.016	0.050
θ	0°	8°	0°	8°



- Note: 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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C3M0021120D DMN6022SSD-13